



ALPHA & OMEGA
SEMICONDUCTOR

AOT9N40
400V,8A N-Channel MOSFET

General Description

The AOT9N40 is fabricated using an advanced high voltage MOSFET process that is designed to deliver high levels of performance and robustness in popular AC-DC applications. By providing low $R_{DS(on)}$, C_{iss} and C_{rss} along with guaranteed avalanche capability this part can be adopted quickly into new and existing offline power supply designs. These parts are ideal for boost converters and synchronous rectifiers for consumer, telecom, industrial power supplies and LED backlighting.

For Halogen Free add "L" suffix to part number:
AOT9N40L

Product Summary

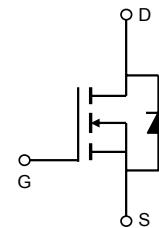
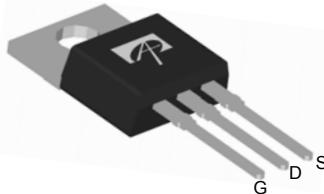
V_{DS}	500V@150°C
I_D (at $V_{GS}=10V$)	8A
$R_{DS(ON)}$ (at $V_{GS}=10V$)	< 0.8Ω

100% UIS Tested
100% R_g Tested



Top View

TO-220



Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

Parameter	Symbol	AOT9N40	Units
Drain-Source Voltage	V_{DS}	400	V
Gate-Source Voltage	V_{GS}	± 30	V
Continuous Drain Current	I_D	8	A
$T_C=100^\circ C$		5	
Pulsed Drain Current ^C	I_{DM}	22	
Avalanche Current ^C	I_{AR}	3.2	A
Repetitive avalanche energy ^C	E_{AR}	150	mJ
Single pulsed avalanche energy ^G	E_{AS}	300	mJ
Peak diode recovery dv/dt	dv/dt	5	V/ns
Power Dissipation ^B	P_D	132	W
Derate above $25^\circ C$		1	W/ $^\circ C$
Junction and Storage Temperature Range	T_J , T_{STG}	-55 to 150	$^\circ C$
Maximum lead temperature for soldering purpose, 1/8" from case for 5 seconds	T_L	300	$^\circ C$

Thermal Characteristics

Parameter	Symbol	AOT9N40	Units
Maximum Junction-to-Ambient ^{A,D}	$R_{\theta JA}$	65	$^\circ C/W$
Maximum Case-to-sink ^A	$R_{\theta CS}$	0.5	$^\circ C/W$
Maximum Junction-to-Case	$R_{\theta JC}$	0.95	$^\circ C/W$

Electrical Characteristics ($T_J=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
STATIC PARAMETERS						
BV_{DSS}	Drain-Source Breakdown Voltage	$I_D=250\mu\text{A}, V_{GS}=0\text{V}, T_J=25^\circ\text{C}$	400			V
		$I_D=250\mu\text{A}, V_{GS}=0\text{V}, T_J=150^\circ\text{C}$		500		
$BV_{DSS}/\Delta T_J$	Zero Gate Voltage Drain Current	$I_D=250\mu\text{A}, V_{GS}=0\text{V}$	0.4	4.5	500	$\text{V}/^\circ\text{C}$
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS}=400\text{V}, V_{GS}=0\text{V}$		1		μA
		$V_{DS}=320\text{V}, T_J=125^\circ\text{C}$		10		
I_{GSS}	Gate-Body leakage current	$V_{DS}=0\text{V}, V_{GS}=\pm 30\text{V}$			± 100	nA
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{DS}=5\text{V}, I_D=250\mu\text{A}$	3.4	4	4.5	V
$R_{DS(\text{ON})}$	Static Drain-Source On-Resistance	$V_{GS}=10\text{V}, I_D=4\text{A}$		0.64	0.8	Ω
g_{FS}	Forward Transconductance	$V_{DS}=40\text{V}, I_D=4\text{A}$		8		S
V_{SD}	Diode Forward Voltage	$I_S=1\text{A}, V_{GS}=0\text{V}$		0.75	1	V
I_S	Maximum Body-Diode Continuous Current				8	A
I_{SM}	Maximum Body-Diode Pulsed Current				22	A
DYNAMIC PARAMETERS						
C_{iss}	Input Capacitance	$V_{GS}=0\text{V}, V_{DS}=25\text{V}, f=1\text{MHz}$	500	630	760	pF
C_{oss}	Output Capacitance		45	73	100	pF
C_{rss}	Reverse Transfer Capacitance		2	5.7	9	pF
R_g	Gate resistance	$V_{GS}=0\text{V}, V_{DS}=0\text{V}, f=1\text{MHz}$	1.2	2.6	4.0	Ω
SWITCHING PARAMETERS						
Q_g	Total Gate Charge	$V_{GS}=10\text{V}, V_{DS}=320\text{V}, I_D=8\text{A}$	10	13.1	16	nC
Q_{gs}	Gate Source Charge			3.9		nC
Q_{gd}	Gate Drain Charge			4.8		nC
$t_{D(\text{on})}$	Turn-On Delay Time	$V_{GS}=10\text{V}, V_{DS}=200\text{V}, I_D=8\text{A}, R_G=25\Omega$		17		ns
t_r	Turn-On Rise Time			52		ns
$t_{D(\text{off})}$	Turn-Off Delay Time			25		ns
t_f	Turn-Off Fall Time			30		ns
t_{rr}	Body Diode Reverse Recovery Time	$I_F=8\text{A}, dI/dt=100\text{A}/\mu\text{s}, V_{DS}=100\text{V}$	150	195	240	ns
Q_{rr}	Body Diode Reverse Recovery Charge	$I_F=8\text{A}, dI/dt=100\text{A}/\mu\text{s}, V_{DS}=100\text{V}$	1.5	1.9	2.3	μC

A. The value of R_{QA} is measured with the device in a still air environment with $T_A=25^\circ\text{C}$.

B. The power dissipation P_D is based on $T_{J(\text{MAX})}=150^\circ\text{C}$, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Repetitive rating, pulse width limited by junction temperature $T_{J(\text{MAX})}=150^\circ\text{C}$. Ratings are based on low frequency and duty cycles to keep initial $T_J=25^\circ\text{C}$.

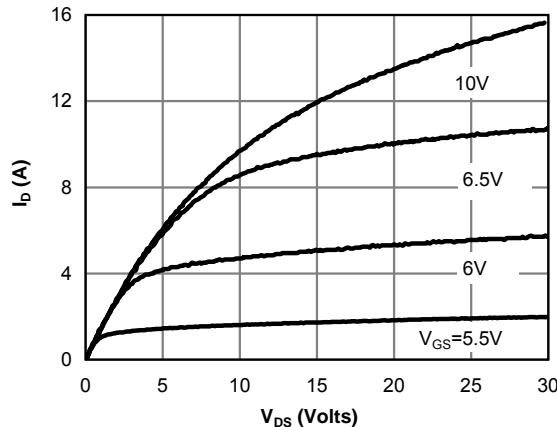
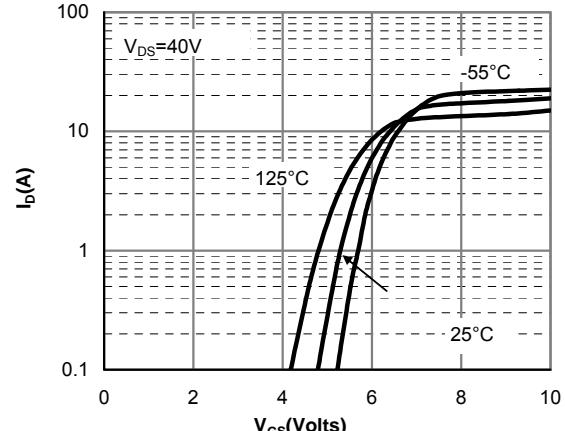
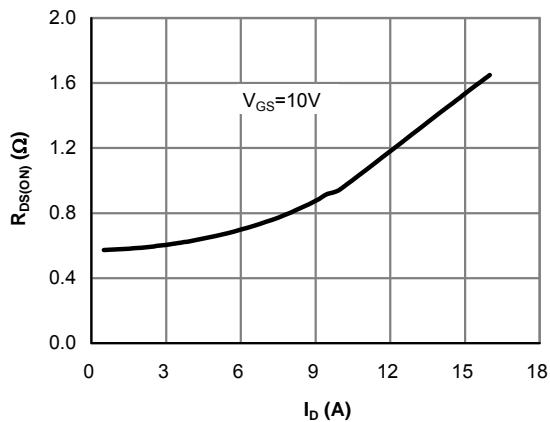
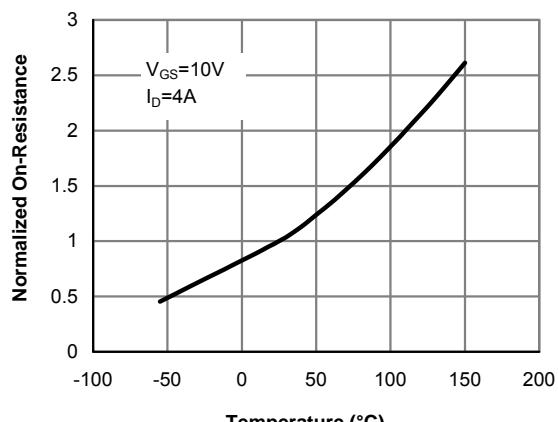
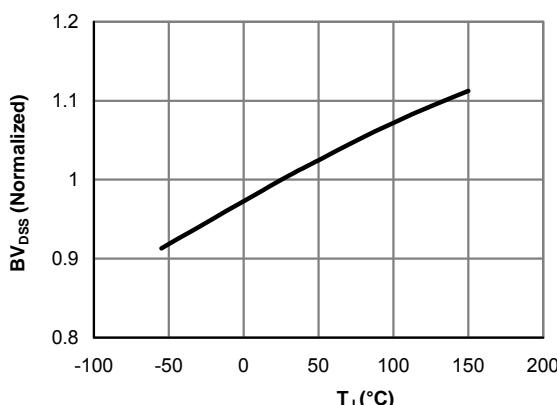
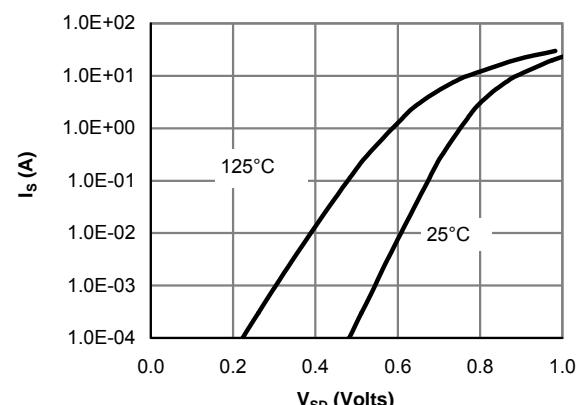
D. The R_{QA} is the sum of the thermal impedance from junction to case R_{JC} and case to ambient.

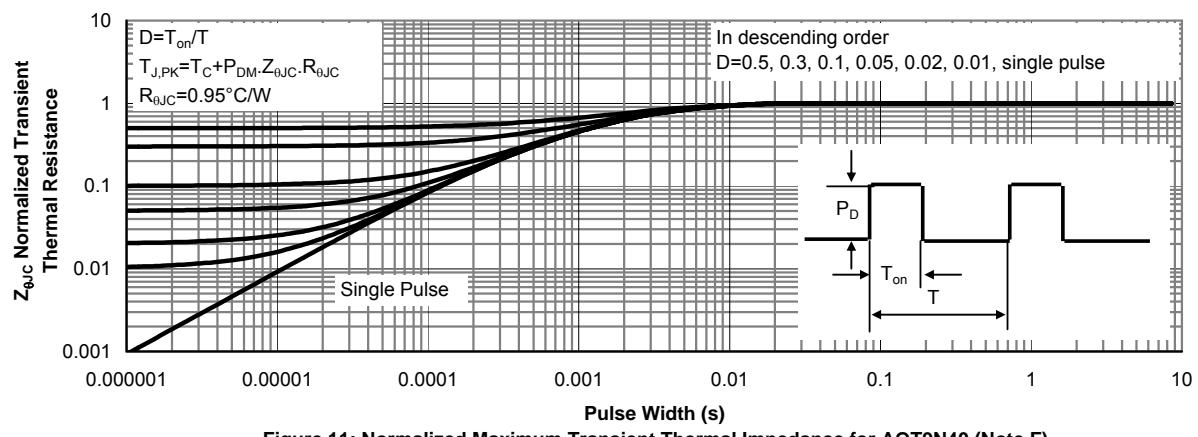
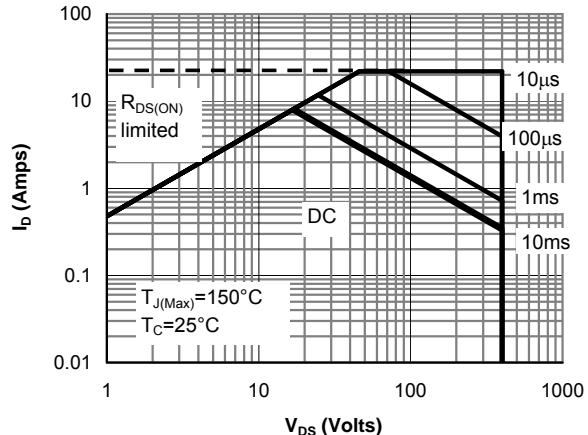
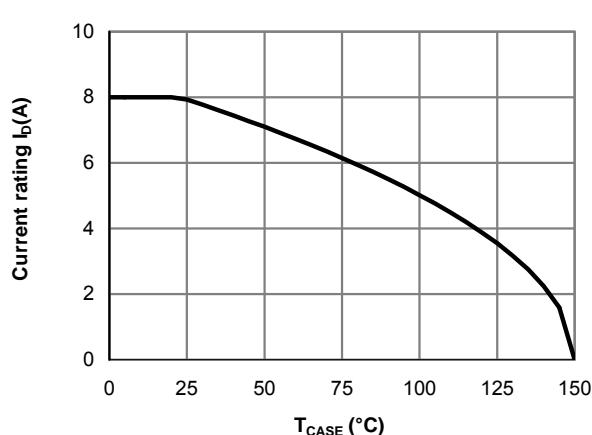
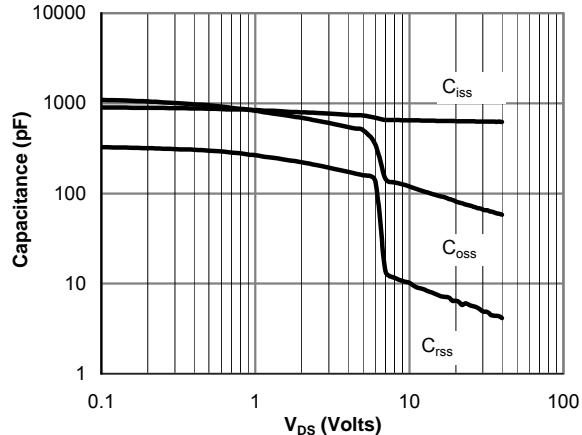
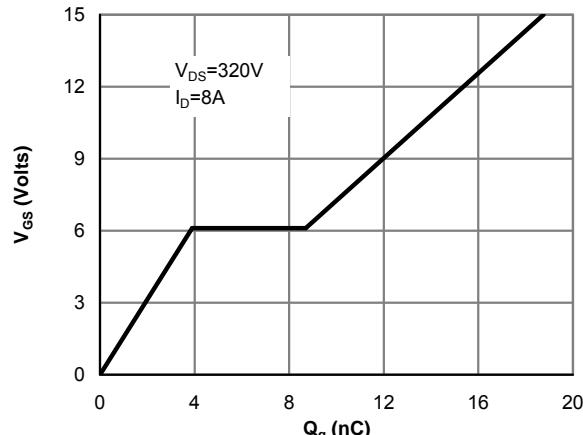
E. The static characteristics in Figures 1 to 6 are obtained using $<300\ \mu\text{s}$ pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(\text{MAX})}=150^\circ\text{C}$. The SOA curve provides a single pulse rating.

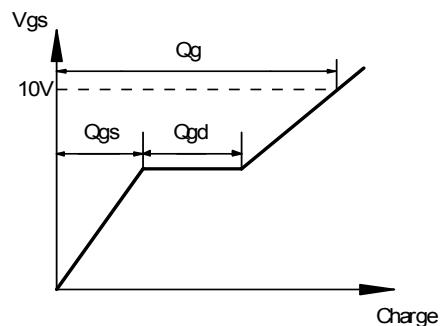
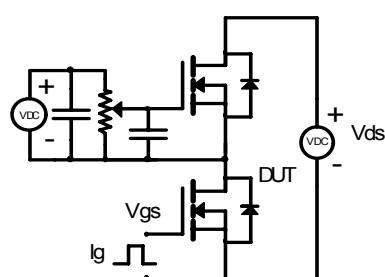
G. $L=60\text{mH}, I_{AS}=3.2\text{A}, V_{DD}=150\text{V}, R_G=25\Omega$, Starting $T_J=25^\circ\text{C}$

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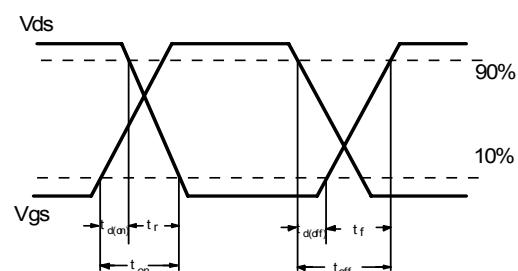
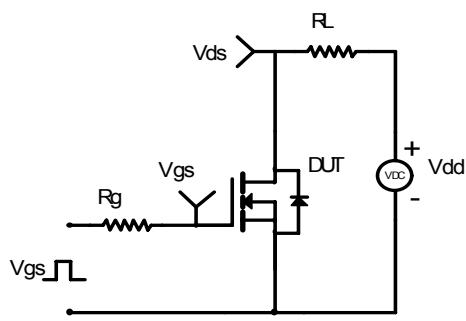
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

Fig 1: On-Region Characteristics

Figure 2: Transfer Characteristics

Figure 3: On-Resistance vs. Drain Current and Gate Voltage

Figure 4: On-Resistance vs. Junction Temperature

Figure 5:Break Down vs. Junction Temparature

Figure 6: Body-Diode Characteristics (Note E)

TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS


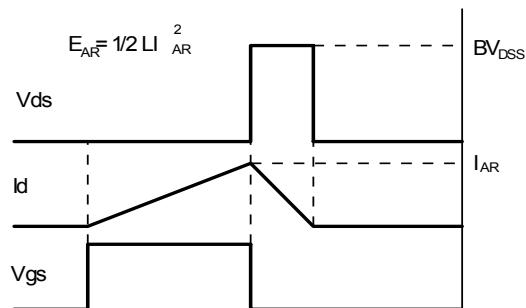
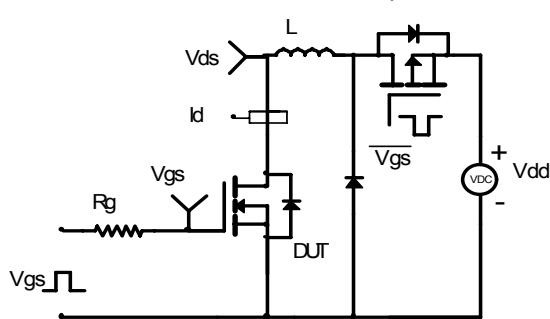
Gate Charge Test Circuit & Waveform



Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms

